# **SPECIFICATION**

SPEC. No. C-150°C-b

D A T E : 2016 Oct.

То

# **Non-Controlled Copy**

CUSTOMER'S PRODUCT NAME

TDK'S PRODUCT NAME

Multilayer Ceramic Chip Capacitors

C Series/ Commercial grade

High Temperature Application

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

### RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

**TDK Corporation** 

Sales

Electronic Components Sales & Marketing Group Engineering

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge		

#### 1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK Corporation Japan,

TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

#### **EXPLANATORY NOTE:**

This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

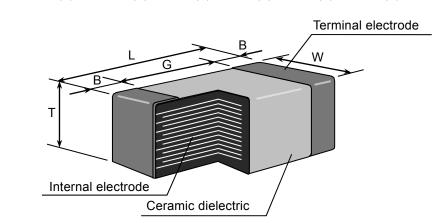
If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

#### 2. CODE CONSTRUCTION

(Example)

(1) Type

Catalog Number:	C1005	<u> X8R</u>	<u>1E</u>	103	<u>K</u>	050	_A_	_A_
(Web)	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
Item Description:	C1005	X8R	<u>1E</u>	103	<u>K</u>	<u>T</u>	XXXX	
	(1)	(2)	(3)	(4)	(5)	(9)	(10)	



<sup>\*</sup>As for dimensions of each product, please refer to detailed inforamtion on TDK web.

(2) Temperature Characteristics (Details are shown in table 1 No.7 and No.8 at page 5)

### (3) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V
1 E	DC 25 V
1 C	DC 16 V
	<u> </u>

#### (4) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 2R2 
$$\rightarrow$$
 2.2pF  
105  $\rightarrow$  1,000,000pF = 1.0  $\mu$  F

(5) Capacitance tolerance

	Symbol	Tolerance	Capacitance
	С	± 0.25 pF	10pE and under
	D	± 0.5 pF	10pF and under
_	J	± 5 %	
-	K	± 10 %	Over 10pF
-	М	± 20 %	

- (6) Thickness code (Only catalog number)
- (7) Package code (Only catalog number)
- (8) Special code (Only catalog number)
- (9) Packaging (Only item description)
  \*Bulk is not applicable for C1005 type.
- (10) Internal code (Only item description)

Symbol	Packaging	
В	Bulk	
Т	Taping	

#### 3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

3.1 Standard combination of rated capacitance and tolerances

Class	Temperature Characteristics	Capacitano	e tolerance	Rated capacitance
		10pF and	C (±0.25pF)	1, 1.5, 2, 2.2, 3, 3.3, 4, 4.7, 5
		under	D (±0.5pF)	6, 6.8, 7, 8, 9, 10
1	NP0	12pF to 10,000pF	J (± 5 %)	E – 12 series
		Over K (± 10,000pF	K (± 10 %)	E – 6 series
2	X8R	K (± 10 %) M (± 20 %)		E – 6 series

3.2 Capacitance Step in E series

E series	Capacitance Step											
E- 6	1.	.0	1.5 2.2 3.3 4.7 6.8				.8					
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

### 4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating	Max. operating	Reference
	Temperature	Temperature	Temperature
NP0, X8R	-55°C	150°C	25°C

### 5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH 6 months Max.

### 6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225, C4532 and C5750 types are more likely to be affected by heat stress from the substrate.

Please inquire separate specification for the large case sizes when mounted on the substrate.

### 7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

### 8. PERFORMANCE

table 1

	T	T	144010 1	I				
No.	Item	Perform	ance	Test or inspection method				
1	External Appearance	No defects which merformance.	Inspect	with magnify	ing g	lass (3	×).	
2	Insulation Resistance	10,000MΩ or 500M (As for the capacitor rated voltage 16V I 100MΩ·μF min.) wh	As for th	ated voltage ne capacitor o 00V DC.			e 630V DC,	
3	Voltage Proof	Withstand test volta insulation breakdow	_	T.C.	Rated voltage(R\	<b>V</b> )	Apply voltage	
		damage.			RV≦100\	<b>/</b>	3 × rate	ed voltage
				NP0	100V <rv≦< td=""><td>500V</td><td colspan="2">1.5 × rated voltage</td></rv≦<>	500V	1.5 × rated voltage	
					500V <r\< th=""><th><b>/</b></th><th colspan="2">1.3 × rated voltage</th></r\<>	<b>/</b>	1.3 × rated voltage	
					RV≦100V		2.5 × rated voltage	
				X8R	100V <rv≦500v< th=""><th colspan="2">1.5 × rated voltage</th></rv≦500v<>		1.5 × rated voltage	
					500V <r\< th=""><th><b>/</b></th><th>1.3 × rat</th><th>ted voltage</th></r\<>	<b>/</b>	1.3 × rat	ted voltage
4	Capacitance	Within the specified	I tolerance.		DC voltage s / discharge of 50mA.			
	'	,		-	Rated	Mea	asuring	Measuring
				T.C.	Capacitance		uency	voltage
				-	1000pF and		· · · · ·	
				NP0	under	1MF	lz±10%	0.5~5Vrms.
					Over 1000pF	1kH	z±10%	
				X8R	All	1kH	z±10%	1.0±0.2Vrms
				For info	ormation whi	ich p	roduct	has which
				measur	ing voltage, epresentative	pleas		
5	Q			See No	.4 in this tab	le for	measu	ring
	(NP0)	Rated capacitance	Q	conditio	n.			
		30pF and over	1000 min.					
		Under 30pF						
		C: Rated capacitan						
6	Dissipation Factor (X8R)	As for D.F. spec of	each product,	See No condition	.4 in this tab n.	le for	measu	ring
		please refer to deta	iled inforamtion					
		on TDK web.						

	inued)		T
No.	Item	Performance	Test or inspection method
7	Temperature Characteristics of Capacitance (NP0)	Temperature Coefficient (ppm/°C)  0 ± 30  Capacitance drift Within ± 0.2% or ±0.05pF, whichever larger.	Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature.  Measuring temperature below 20°C shall be -10°C and -25°C.
8	Temperature Characteristics	Capacitance Change (%)	Capacitance shall be measured by the steps shown in the following table after
	of Capacitance (X8R)	No voltage applied	thermal equilibrium is obtained for each step.
	(7.5.1)	±15(%)	∆C be calculated ref. STEP3 reading
			Step Temperature(°C)
			1 25 ± 2
			2 -55 ± 2
			3 25 ± 2
			4 150 ± 2
9	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C. board shown in Appendix2 and apply a pushing force of 2N (C1005) or 5N (C1608, C2012, C3216, C3225, C4532, C5750) with 10±1s.  Pushing force  P.C. board
10	Bending	No mechanical damage.	Reflow solder the capacitors on a P.C. board shown in Appendix1 and bend it for 1mm.  20 FR230 (Unit:mm)

No.	o. Item		Performance		Test or inspection method		
11	Solderability		New solder to contermination. 25% may have pospots but not conspot. Ceramic surface not be exposed of shifting of termination.	in holes or rough acentrated in one of A sections shall due to melting or	Completely soak both terminations in solder at the following conditions.  Solder: Sn-3.0Ag-0.5Cu or Sn-37Pb Temperature: 245±5°C(Sn-3.0Ag-0.5Cu)		
12	Resistance to solder heat	nce External No cracks are allowed and			Completely soak both terminations in solder at the following conditions. 260±5°C for 10±1s.  Preheating condition     Temp.: 110 ~ 140°C     Time : 30 ~ 60s.  Solder : Sn-3.0Ag-0.5Cu or Sn-37Pb  Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.		
		Q (NP0)  D.F. (X8R)  Insulation Resistance	Meet the initial spec.  Meet the initial spec.  Meet the initial spec.		Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.		
	Voltage No insulation breakdown or other proof damage.						

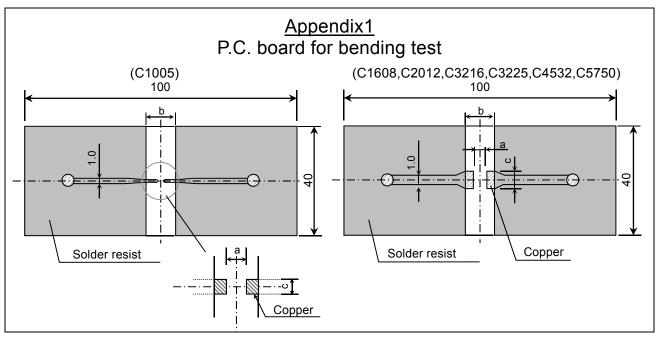
No.	Ite	em	Perf	ormance		Test or inspection m	nethod
13	Vibration	External appearance	No mechanical	damage.		solder the capaciton board shown in Appe	
		Capacitance			-	testing.  Vibrate the capacitors with amplitude o	
			Characteristics	Change from the value before test			
			NP0	±2.5% or ±0.25pF, whichever larger.	1.5mm	P-P changing the fr	equencies
			X8R	± 7.5 %	from 10Hz to 55Hz and back to 10Hz about 1min.  Repeat this for 2h each in 3 perpendicular directions.		
		Q (NP0)	Meet the initial spec.				
		D.F. (X8R)	Meet the initial spec.				
14	Temperature cycle	External appearance	No mechanical damage.		Reflow solder the capacitors on a P.C. board shown in Appendix2 before		
		Capacitance			testing		
		·	Characteristics	Change from the value before test	Expos	e the capacitors in th	ne condition
			NP0	±2.5% or ±0.25pF, whichever larger.	step1 through step 4 and repeat 5 times consecutively.		epeat 5 times
			X8R	± 7.5 %		the capacitors in am	
						2) before measurem	•
		Q (NP0)	Meet the initial	spec.	Step	Temperature(°C)	Time (min.)
		D.F.	Meet the initial	spec.	1	-55 ± 3	30 ± 3
		(X8R)		•	2	25	2 - 5
		Insulation Resistance	Meet the initial	spec.	3 150 ± 2 3		30 ± 2
		Voltage proof	No insulation breakdown or other damage.		4	25	2 - 5

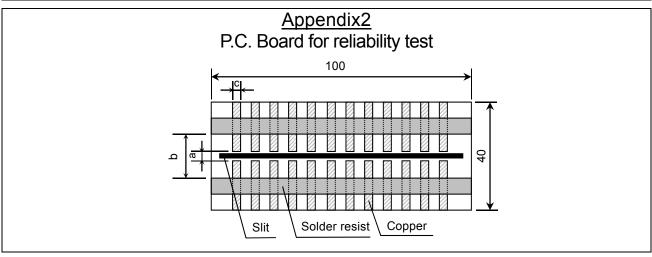
No.	Item		Perfo	rmance	Test or inspection method
15	Moisture Resistance	desistance appearance		Reflow solder the capacitors on a P.C. board shown in Appendix2	
	(Steady State)	Capacitance	Characteristics	Change from the value before test	before testing. Leave at temperature $40 \pm 2^{\circ}$ C,
			NP0	±5% or ±0.5pF, whichever larger.	90 to 95%RH for 500 +24,0h.
			X8R	± 12.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24 ± 2h (Class2) before
		Q	Rated Capacitan	ce Q	measurement.
		(NP0)	30pF and over	350 min.	
			10pF and over under 30pF	275+5/2×C min.	
			Under 10pF	200+10×C min.	
			C : Rated capacitance (pF)		
		D.F. (X8R)	200% of initial spe	ec. max.	
		Insulation Resistance	1,000M $\Omega$ or 50M $\Omega$ ·μF min.		
			(As for the capac		
			rated voltage 16\		
			or 10MΩ·μF min.	) whichever smaller.	

No.	Item		Perfo	ormance	Test or inspection method
16	Resistance appearance		Reflow solder the capacitors on a P.C. board shown in Appendix2		
		Capacitance	Characteristics NP0 X8R	Change from the value before test ±7.5% or ±0.75pF, whichever larger.	before testing.  Apply the rated voltage at temperature 40±2°C and 90 to 95%RH for 500 +24,0h.  Charge/discharge current shall not exceed 50mA.  Leave the capacitors in ambient
		Q (NP0)	Rated Capacitan  30pF and over  Under 30pF  C : Rated capaci	200 min. 100+10/3×C min.	condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.  Voltage conditioning (only for class 2) Voltage treat the capacitors under
		D.F. (X8R)	200% of initial sp	ec. max.	testing temperature and voltage for 1hour.
		Insulation Resistance	500MΩ or 25MΩ (As for the capacitated voltage 16\ or 5MΩ·μF min.)	citors of	<ul> <li>Leave the capacitors in ambient condition for 24±2h before measurement.</li> <li>Use this measurement for initial value</li> </ul>

No.			Perfo	rmance	Test or inspection method
17	appearance  Capacitance  Characteristics  Change from the value before test  +3% or +0.3nE  a P.C. board before testin  Below the volume before test  150 ±2°C for		No mechanical da	amage.	Reflow solder the capacitors on a P.C. board shown in Appendix2
		Below the voltage shall be applied at 150 ±2°C for 1,000 +48,0h.			
			NP0	±3% or ±0.3pF, whichever larger.	
					Applied Voltage
			X8R	± 15 %	Rated voltage x2
					Rated voltage x1.5
					Rated voltage x1.2
		Q (NP0)			Rated voltage x1
			Rated Capacitance		As for each adverter of each and each
			30pF and over	350 min.	As for applied voltage, please contact
			10pF and over unde 30pF	275+5/2×C min.	with our sales representative.
				Under 10pF	200+10×C min.
			C : Rated capacitance (pF)		Charge/discharge current shall not exceed 50mA.
		D.F.	200% of initial spe	ec. max.	Leave the capacitors in ambient
		(X8R)			condition for 6 to 24h (Class1) or
		Insulation Resistance	1,000MΩ or 50MΩ		24±2h (Class2) before measurement.
			(As for the capaci	itors of ′ DC, 1,000MΩ or	Voltage conditioning (only for class 2)
			10MΩ·µF min.) w		Voltage treat the capacitors under
					testing temperature and voltage for
					1hour.
					Leave the capacitors in ambient
					condition for 24±2h before
					measurement.
					Use this measurement for initial value

<sup>\*</sup>As for the initial measurement of capacitors (X8R) on number 8,12,13,14 and 15, leave capacitors at 150  $-10,0^{\circ}$ C for 1 hour and measure the value after leaving capacitors for 24 ± 2h in ambient condition.





(It is recommended to provide a slit on P.C. board for C3225, C4532 and C5750.)

(Unit: mm)

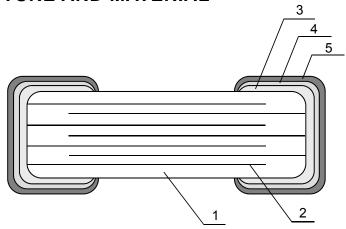
Туре	Dimensions			
TDK(EIA style)	а	b	С	
C1005 (CC0402)	0.4	1.5	0.5	
C1608 (CC0603)	1.0	3.0	1.2	
C2012 (CC0805)	1.2	4.0	1.65	
C3216 (CC1206)	2.2	5.0	2.0	
C3225 (CC1210)	2.2	5.0	2.9	
C4532 (CC1812)	3.5	7.0	3.7	
C5750 (CC2220)	4.5	8.0	5.6	

1. Material : Glass Epoxy (As per JIS C6484 GE4) Copper(Thickness:0.035mm)
Solder resist

2. Thickness : Appendix 1 — 0.8mm (C1005)
— 1.6mm (C1608,C2012,C3216,C3225,C4532,C5750)

: Appendix 2 — 1.6mm

### 9. INSIDE STRUCTURE AND MATERIAL



No	NAME	MATERIAL		
No.	INAIVIE	NP0	X8R	
1	Dielectric	CaZrO <sub>3</sub>	BaTiO <sub>3</sub>	
2	Electrode	Nickel (Ni)		
3		Copper (Cu)		
4	Termination	Nicke	l (Ni)	
5		Tin (Sn)		

### 10. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Total number of components in a plastic bag for bulk packaging : 1000pcs (C1005 types are not applicable.)
- 2) Tape packaging is as per TDK tape packaging specification.
  - 1) Inspection No.
  - 2) TDK P/N
  - 3) Customer's P/N
  - 4) Quantity

\*Composition of Inspection No.

Example 
$$\underline{F}$$
  $\underline{6}$   $\underline{A}$   $\underline{OO}$   $\underline{OOO}$  (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

### 11. RECOMMENDATION

As for C3225 and larger, It is recommended to provide a slit (about 1mm width) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

### 12. SOLDERING CONDITION

As for C1005, C3225, C4532 and C5750 types, reflow soldering only.

# 13. Caution

No.	Process	Condition		
		1-1. Storage		
1	Operating Condition (Storage, Transportation)	<ol> <li>The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.</li> <li>The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur.</li> <li>Avoid storing in sun light and falling of dew.</li> <li>Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.</li> <li>Capacitors should be tested for the solderability when they are stored for long time.</li> <li>Handling in transportation         <ul> <li>In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition.</li> </ul> </li> </ol>		
		(Refer to JEITA RCR-2335C 9.2 Handling in transportation)		
2	Circuit design  ⚠ Caution	2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.  1) Do not use capacitors above the maximum allowable operating temperature. 2) Surface temperature including self heating should be below maximum operating temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C) 3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.  2-2. Operating voltage  1) Operating voltage across the terminals should be below the rated voltage.  When AC and DC are super imposed, V <sub>0-P</sub> must be below the rated voltage.  — (1) and (2)  AC or pulse with overshooting, V <sub>P-P</sub> must be below the rated voltage.  — (3), (4) and (5)  When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.		
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage  Positional Measurement (Rated voltage)  Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)  Positional Measurement (Rated voltage)  V <sub>P-P</sub>		

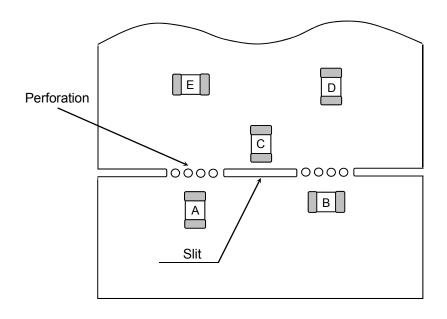
No.	Process			Condition		
2	Circuit design  ⚠ Caution	reliability of th	e capacitors may capacitance will s should be sele	y be reduced.  vary depending	on applied DC ar	
		capacitors m	pacitors (Class 2 nay vibrate thems	elves and gener	rate audible sour	nd.
3	Designing P.C.board	<ul> <li>The amount of solder at the terminations has a direct effect on the reliability of the capacitors.</li> <li>1) The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations.</li> <li>2) Avoid using common solder land for multiple terminations and provide individual solder land for each terminations.</li> </ul>				chip capacitors, and, determine the older on the
		3) Size and reco	mmended land o	limensions.		
			C	hip capacitors	Solder land	
			<i></i>	_		
			c		+	Solder resist
			В	Α	<i>(////////////////////////////////////</i>	
		Flow solder	ing ←	<del></del>		(mm)
		Type Symbol	C1608 (CC0603)	C2012 (CC0805	C321 (CC12	
		A	0.7 - 1.0	1.0 - 1.3	3 2.1 - 2	2.5
		B	0.8 - 1.0	1.0 - 1.2		
		C	0.6 - 0.8	0.8 - 1.1	1.0 - 1	1.3
		Reflow sold				(mm)
		Type Symbol	C1005 (CC0402)	C1608 (CC0603)	C2012 (CC0805)	
		А	0.3 - 0.5	0.6 - 0.8	0.9 - 1.2	-
		В	0.35 - 0.45	0.6 - 0.8	0.7 - 0.9	_
		C	0.4 - 0.6	0.6 - 0.8	0.9 - 1.2	_
		Type Symbol	C3216 (CC1206)	C3225 (CC1210)	C4532 (CC1812)	C5750 (CC2220)
		A	2.0 - 2.4	2.0 - 2.4	3.1 - 3.7	4.1 - 4.8
		В	1.0 - 1.2	1.0 - 1.2	1.2 - 1.4	1.2 - 1.4
		C	1.1 - 1.6	1.9 - 2.5	2.4 - 3.2	4.0 - 5.0

No.	Process		Condition	
3	Designing P.C. board	4) Recommende	d chip capacitors layout is as follo	wing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit	Perforation or slit
			Break P.C. board with mounted side up.	Break P.C. board with mounted side down.
			Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit
		Chip arrangement (Direction)	Perforation or slit	Perforation or slit
		Distance from slit	Closer to slit is higher stress $(\ell_1 < \ell_2)$	Away from slit is less stress $\ell_2$ $(\ell_1 \!<\! \ell_2)$
			1	1

#### Condition No. Process 3

### Designing P.C. board

5) Mechanical stress varies according to location of chip capacitors on the P.C. board.

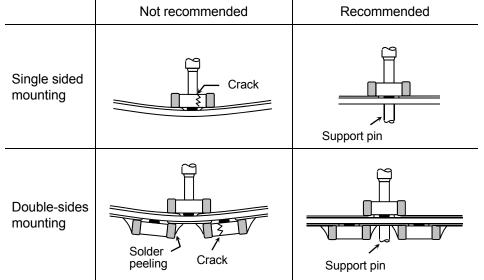


The stress in capacitors is in the following order. A > B = C > D > E

### 6) Layout recommendation

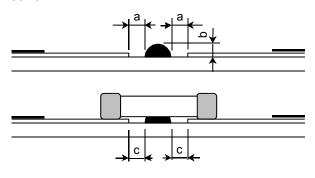
Example	Use of common solder land	Soldering with chassis	Use of common solder land with other SMD
Need to avoid	Lead wire Chip Solder PCB Adhesive Solder land	Chassis  Excessive solder	Solder land  Excessive solder  Missing solder land
Recommen- dation	Lead wire Solder resist	Solder resist $\ell_2 > \ell_1$	Solder resist

No.	Process		Condition	
4	Mounting	capacitors to res  1) Adjust the bottom surface and no  2) Adjust the mou  3) To minimize the	ounting head nead is adjusted too low, it may in ult in cracking. Please take followir om dead center of the mounting he	ng precautions.  and to reach on the P.C. board  of static weight.
		See following examples.  Not recommended Recommended		



When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

### 4-2. Amount of adhesive



Example: C2012 (CC0805), C3216 (CC1206)

а	0.2mm min.	
b	70 - 100μm	
С	Do not touch the solder land	

No.	Process		Co	ondition			
5	<ul> <li>5 Soldering</li> <li>5-1. Flux selection     Although highly-activated flux gives better solderability, substances which activity may also degrade the insulation of the chip capacitors. To avoid degradation, it is recommended following.</li> <li>1) It is recommended to use a mildly activated rosin flux (less than 0.1% Strong flux is not recommended.</li> <li>2) Excessive flux must be avoided. Please provide proper amount of flux</li> <li>3) When water-soluble flux is used, enough washing is necessary.</li> </ul>					oid such .1wt% chlorine).	
		Wave solder	5-2. Recommended soldering profile by various methods  Wave soldering  Soldering  Preheating  Natural cooling  Preheating  Natural cooling  Natural cooling  Natural cooling				
	Een (Co) compt	Peak Temp o Over 60 sec.	Over 60 sec.	Peak Temp (O) Ove	r 60 sec.	Temp time	
		Manual sol (Solder i	3sec. (As short as p	As for and C solder As for C4532 applie	CATION C1608 (CC0603), 0 3216 (CC1206), ap ing and reflow solde C1005 (CC0402), 2 (CC1812) and C5 d only to reflow sold	plied to wave ering. C3225 (CC1210), 750 (CC2220), dering.	
		5-3. Recommended sold	ecommended soldering peak temp and peak temp duration				
		wave soldering Renow solder					
		Solder Sn-Pb Solder	Peak temp(°C)  250 max.	Duration(sec.)  3 max.	Peak temp(°C)  230 max.	Duration(sec.) 20 max.	
		Lead Free Solder	260 max.	5 max.	260 max.	10 max.	
		Recommended solde Sn-37Pb (Sn-Pb sol	er compositions	1			

Sn-3.0Ag-0.5Cu (Lead Free Solder)

No.	Process	Condition				
5	Soldering	5-4. Avoiding thermal shock				
		Preheating condition	tion			
		Soldering	_	Type		Temp. (°C)
		Wave solde	arina i .	CC0603), C2012(C CC1206)	C0805),	ΔT ≤ 150
		Reflow solds	C2012(	CC0402), C1608(C) CC0805), C3216(C)	C1206)	ΔT ≤ 150
			C5750(	CC1210), C4532(C) CC2220)		ΔT ≤ 130
		Manual sold	ering C2012(	CC0402), C1608(C CC0805), C3216(C	C1206)	ΔT ≤ 150
			C3225(	CC1210), C4532(C CC2220)	C1812),	ΔT ≤ 130
		temperature c	Ider will induc	e higher tensile may result in chip	force in chip	capacitors wher fficient solder may
		Excessive solder				sile force in itors to cause
		Adequate			Maximum amour Minimum amoun	
		Insufficient solder				tact failure or titors come off
		land size. The hi heat shock may Please make su time in accordan	oldering iron tip of solder iron v gher the tip ten cause a crack re the tip temp. ace with followir	aries by its type, I nperature, the qui in the chip capaci before soldering ng recommended on in 5-4 to avoid	cker the operati tors. and keep the pe condition. (Plea	on. However, eak temp and se preheat the
		Recommended	solder iron cor	ndition (Sn-Pb Sol	der and Lead F	ree Solder)
		Туре	Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)
		C1005(CC0402) C1608(CC0603) C2012(CC0805) C3216(CC1206)	350 max.	3 max.	20 max.	Ø 3.0 max.
		C3225(CC1210) C4532(CC1812) C5750(CC2220)	280 max.			

No.	Process	Condition				
5	Soldering	<ol> <li>Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.</li> </ol>				
	<ul> <li>5-7. Soldering rework using spot heater Heat stress during rework may possibly be reduced by using a spot heater (also called a "blower") rather than a soldering iron. It is applied only to adding solder in the case of insufficient solder amount.</li> <li>1) Reworking using a spot heater may suppress the occurrence of cracks in capacitor compared to using a soldering iron. A spot heater can heat up a uniformly with a small heat gradient which leads to lower thermal stress of quick heating and cooling or localized heating.  Moreover, where ultra-small capacitors are mounted close together on a circuit board, reworking with a spot heater can eliminate the risk of direct between the tip of a soldering iron and a capacitor.</li> </ul>					
		2) Rework condition  If the blower nozzle of a spot heater is too close to a capacitor, a crack in the capacitor may occur due to heat stress. Below are recommendations for avoiding such an occurrence.  Keep more than 5mm between a capacitor and a spot heater nozzle.  The blower temperature of the spot heater shall be lower than 400°C.  The airflow shall be set as weak as possible.  The diameter of the nozzle is recommended to be 2mm(one-outlet type). The size is standard and common.  Duration of blowing hot air is recommended to be 10s or less for C1608 (CC0603), C2012 (CC0805) and C3216 (CC1206), and 30s or less for C3225 (CC1210), C4532 (CC1812) and C5750 (CC2220), considering surface area of the capacitor and melting temperature of solder.  The angle between the nozzle and the capacitor is recommended to be 45degrees in order to work easily and to avoid partial area heating.  As is the case when using a soldering iron, preheating reduces thermal stress on capacitors and improves operating efficiency.				
		• Recommended rework condition (Consult the component manufactures for details.)				
		Distance from nozzle 5mm and over				
		Nozzle angle 45degrees				
		Nozzle temp. 400°C and less				
		Set as weak as possible  Airflow  (The airflow shall be the minimum value necessary for solder to melt in the conditions mentioned above.)				
		Nozzle diameter $\phi$ 2mm (one-outlet type)				
		Blowing duration 10s and less (C1608[CC0603], C2012[CC0805], C3216[CC1206]) 30s and less (C3225[CC1210], C4532[CC1812], C5750[CC2220])				
	Example of recommended spot heater use					
		One-outlet type nozzle Angle: 45degrees				

No.	Process	Condition
5	Soldering	3) Amount of solder should be suitable to from a proper fillet shape.  Excess solder causes mechanical and thermal stress on a capacitor and results in cracks. Insufficient solder causes weak adherence of the capacitor to the substrate and may result in detachment of a capacitor and deteriorate reliability of the printed wiring board.  See the example of appropriate solder fillet shape for 5-5.Amount of solder.
		5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder.
		5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering.
		(Refer to JEITA RCR-2335C Annex A (Informative) Recommendations to prevent the tombstone phenomenon)
6	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing     (1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.

No.	Process	Condition
7	Coating and molding of the P.C. board	<ol> <li>When the P.C. board is coated, please verify the quality influence on the product.</li> <li>Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li> <li>Please verify the curing temperature.</li> </ol>
8	Handling after chip mounted ⚠ Caution	1) Please pay attention not to bend or distort the P.C. board after soldering in handling otherwise the chip capacitors may crack.  Bend  Twist  Twist  2) Printed circuit board cropping should not be carried out by hand, but by using the proper tooling. Printed circuit board cropping should be carried out using a board cropping jig as shown in the following figure or a board cropping apparatus to prevent inducing mechanical stress on the board.  (1)Example of a board cropping jig  Recommended example: The board should be pushed from the back side close to the cropping jig so that the board is not bent and the stress applied to the capacitor is compressive.  Unrecommended example: If the pushing point is far from the cropping jig and the pushing direction is from the front side of the board, large tensile stress is applied to the capacitor, which may cause cracks.
		Outline of jig  Recommended  Unrecommended  Printed circuit board  Printed circuit board  Slot  Slot  Slot  Slot  Slot  Components  Slot  Slot  Slot  Slot  Slot  Unrecommended  Load point  Load point  Printed circuit board  V-groove  Slot  Slot

	.								
No.	Process			Conditio					
8	Handling after chip mounted	An ou top a V-gro Unred	nd bottom blades loves on printed commended exar m, right and left,	circuit board cr are aligned with circuit board wh mple: Misalignn	ropping machir th one another en cropping th nent of blade p	ne is shown below. The along the lines with the e board. Dosition between top an ay cause a crack in the			
			Outline of macl	nine	Principl	e of operation			
			Printed circuit board  Cross-section diagram  Printed circuit board  Printed circuit board  Top blade						
					Printed circuit bo	Top blade			
					V-groc	ove Bottom blade			
			Decemmended	Unrecommended					
			Recommended  Top blade	Top-bottom misalignment	Left-right misalignment	Front-rear misalignment			
			Board Board Bottom blade	Top blade  Bottom blade	Top blade  Bottom blade	Top blade  Bottom blade			
		to be adju	When functional check of the P.C. board is performed, check pin pressure te to be adjusted higher for fear of loose contact. But if the pressure is excessive and bend the P.C. board, it may crack the chip capacitors or peel the termination off. Please adjust the check pins not to bend the P.C. board.						
		Item	Not recon	nmended	Re	commended			
		Board bending		Termination peeling  Check pin		Support pin  Check pin			
			_	- Oncor pin					

No.	Process	Condition
9	Handling of loose chip capacitors	If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care.  Crack  Floor
		2) Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack.  Crack  P.C.board
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
12	Caution during operation of equipment	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock.     Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand.     Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		<ol> <li>Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments.</li> <li>Environment where a capacitor is spattered with water or oil</li> <li>Environment where a capacitor is exposed to direct sunlight</li> <li>Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation</li> <li>Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.)</li> <li>Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits.</li> <li>Atmosphere change with causes condensation</li> </ol>
13	Others  A Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		<ul> <li>(1) Aerospace/Aviation equipment</li> <li>(2) Transportation equipment (cars, electric trains, ships, etc.)</li> <li>(3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2)</li> <li>(4) Power-generation control equipment</li> <li>(5) Atomic energy-related equipment</li> <li>(6) Seabed equipment</li> <li>(7) Transportation control equipment</li> <li>(8) Public information-processing equipment</li> <li>(9) Military equipment</li> <li>(10) Electric heating apparatus, burning equipment</li> <li>(11) Disaster prevention/crime prevention equipment</li> <li>(12) Safety equipment</li> <li>(13) Other applications that are not considered general-purpose applications</li> </ul>
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

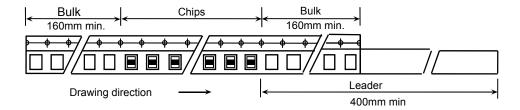
### 14. TAPE PACKAGING SPECIFICATION

### 1. CONSTRUCTION AND DIMENSION OF TAPING

### 1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4. Dimensions of plastic tape shall be according to Appendix 5, 6.

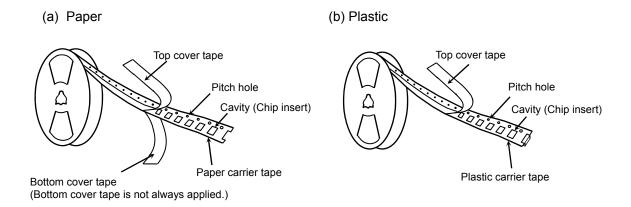
### 1-2. Bulk part and leader of taping



#### 1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8. Dimensions of Ø330 reel shall be according to Appendix 9, 10.

### 1-4. Structure of taping



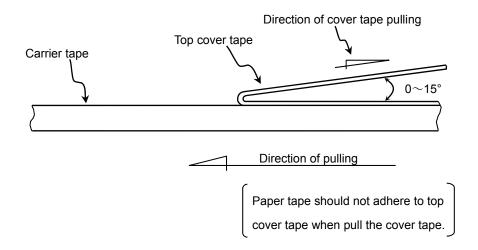
### 2. CHIP QUANTITY

As for chip quantity and taping material of each product, please refer to detailed inforamtion on TDK web.

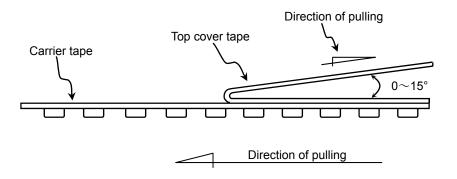
### 3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05-0.7N. (See the following figure.)

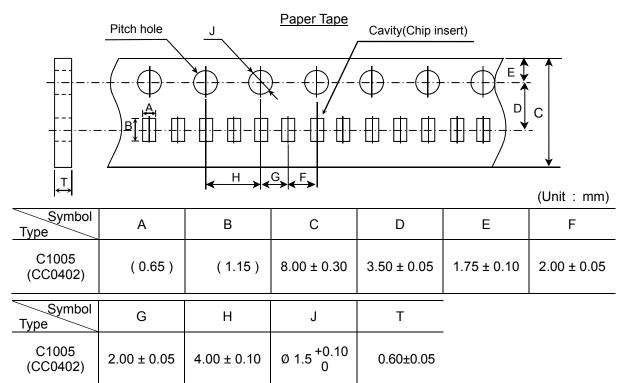
⟨Paper⟩



⟨Plastic⟩

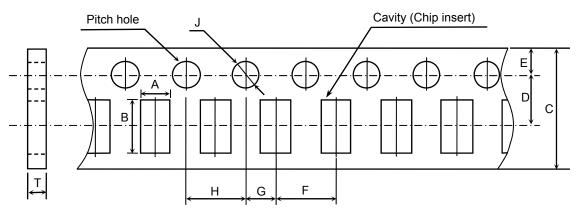


- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



<sup>( )</sup> Reference value.

### Paper Tape

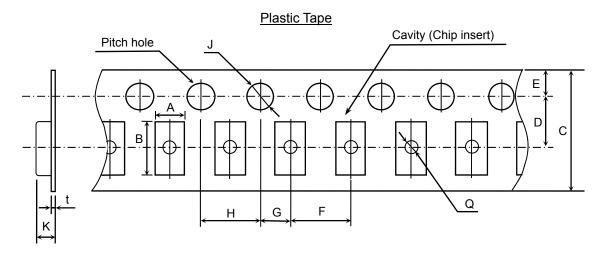


(Unit: mm)

Symbol Type	А	В	С	D	E	F
C1608 (CC0603)	(1.10)	( 1.90 )				
C2012 (CC0805)	( 1.50 )	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3216 (CC1206)	(1.90)	(3.50)				
Symbol	0	1.1		т	•	

Symbol Type	G	Н	J	Т
C1608 (CC0603)				
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	1.20 max.
C3216 (CC1206)				

<sup>( )</sup> Reference value.



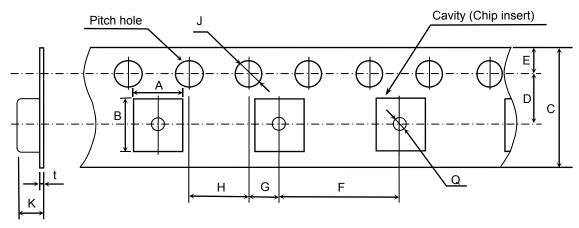
(Unit: mm)

Symbol Type	А	В	С	D	E	F
C2012 (CC0805)	( 1.50 )	( 2.30 )	0.00 + 0.20	2 50 1 0 05		
C3216 (CC1206)	( 1.90 )	(3.50)	$8.00 \pm 0.30$ $*12.0 \pm 0.30$	3.50 ± 0.05 *5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 (CC1210)	(2.90)	(3.60)	* 12.0 ± 0.00	#3.30 <u>1</u> 0.03		
Symbol	G	Н	J	K	t	Q
Type	0	11	3	K	·	ď
C2012 (CC0805)	0	- 11	3	K		<u> </u>
C2012	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 <sup>+0.10</sup>	3.20 max.	0.60 max.	Ø 0.50 min.

<sup>)</sup> Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory. \*Applied to thickness, 2.5mm products.

### Plastic Tape

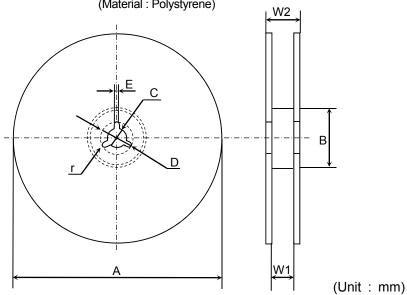


(Unit:mm)

Symbol Type	Α	В	С	D	E	F
C4532 (CC1812)	(3.60)	(4.90)	12.0 ± 0.30	5 50 ± 0.05	1.75 ± 0.10	9.00 ± 0.10
C5750 (CC2220)	(5.40)	(6.10)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
Symbol Type	G	Н	J	К	t	Q
C4532 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	ø 1.5 +0.10	6 50 may	0.60 may	Ø 1.50 min.
C5750 (CC2220)	2.00 ± 0.05	4.00 ± 0.10	0 0.5	6.50 max.	0.60 max.	Ø 1.50 min.

) Reference value.

C1005, C1608, C2012, C3216, C3225 (As for C3225 type, any thickness of the item except 2.5mm ) (Material : Polystyrene)

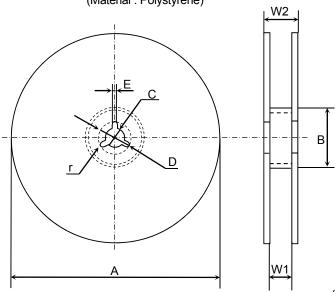


Symbol	Α	В	С	D	Е	$W_1$
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	$W_2$	r	
Dimension	13.0 ± 1.4	1.0	

### **Appendix 8**

C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products ) (Material : Polystyrene)

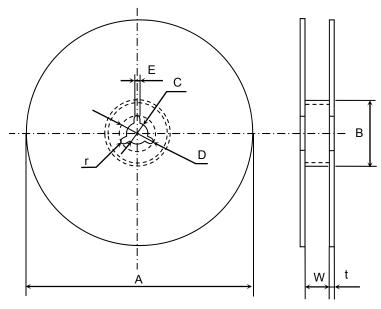


(Unit: mm)

Symbol	А	В	С	D	Е	$W_1$
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

Symbol	$W_2$	r	
Dimension	17.0 ± 1.4	1.0	

C1005, C1608, C2012, C3216, C3225 (As for C3225 type, any thickness of the item except 2.5mm ) (Material : Polystyrene)

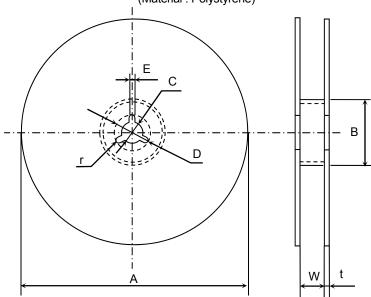


Symbol	Α	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r	
Dimension	2.0 ± 0.5	1.0	

# Appendix 10

C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products ) (Material : Polystyrene)



(Unit: mm)

(Unit: mm)

Symbol	Α	В	С	D	Е	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	r	
Dimension	2.0 ± 0.5	1.0	